

## P-Ch 40V Fast Switching MOSFETs

### Features

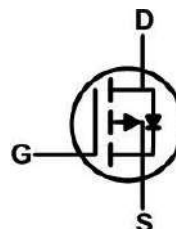
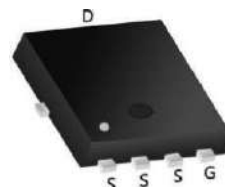
- ★ Super Low Gate Charge
- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

### Description

The KPRA4119 is the high cell density trench P-Ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The KPRA4119 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

### PRPAK5X6 Pin Configuration



### Product Summary

| BVDSS | RDSON | ID    |
|-------|-------|-------|
| -40V  | 3.8mΩ | -115A |

### Absolute Maximum Ratings

| Symbol                                | Parameter                                                     | Rating     | Units |
|---------------------------------------|---------------------------------------------------------------|------------|-------|
| V <sub>DS</sub>                       | Drain-Source Voltage                                          | -40        | V     |
| V <sub>GS</sub>                       | Gate-Source Voltage                                           | ±20        | V     |
| I <sub>D</sub> @T <sub>C</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> | -115       | A     |
| I <sub>D</sub> @T <sub>C</sub> =100°C | Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> | -73        | A     |
| I <sub>DM</sub>                       | Pulsed Drain Current <sup>2</sup>                             | -580       | A     |
| EAS                                   | Single Pulse Avalanche Energy <sup>3</sup>                    | 1250       | mJ    |
| I <sub>AS</sub>                       | Avalanche Current                                             | -70.7      | A     |
| P <sub>D</sub> @T <sub>C</sub> =25°C  | Total Power Dissipation <sup>4</sup>                          | 83.3       | W     |
| P <sub>D</sub> @T <sub>C</sub> =100°C | Total Power Dissipation <sup>4</sup>                          | 33.3       | W     |
| T <sub>STG</sub>                      | Storage Temperature Range                                     | -55 to 150 | °C    |
| T <sub>J</sub>                        | Operating Junction Temperature Range                          | -55 to 150 | °C    |

### Thermal Data

| Symbol           | Parameter                                        | Typ. | Max. | Unit |
|------------------|--------------------------------------------------|------|------|------|
| R <sub>θJA</sub> | Thermal Resistance Junction-Ambient <sup>1</sup> | ---  | 62   | °C/W |
| R <sub>θJC</sub> | Thermal Resistance Junction-Case <sup>1</sup>    | ---  | 1.5  | °C/W |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

| Symbol              | Parameter                                      | Conditions                                        | Min. | Typ. | Max.      | Unit       |
|---------------------|------------------------------------------------|---------------------------------------------------|------|------|-----------|------------|
| BV <sub>DSS</sub>   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V, I_D=-250\mu A$                        | -40  | ---  | ---       | V          |
| R <sub>DS(on)</sub> | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=-10V, I_D=-30A$                           | ---  | 3.1  | 3.8       | m $\Omega$ |
|                     |                                                | $V_{GS}=-4.5V, I_D=-20A$                          | ---  | 4.0  | 5.6       |            |
| V <sub>GS(th)</sub> | Gate Threshold Voltage                         | $V_{GS}=V_{DS}, I_D=-250\mu A$                    | -1.0 |      | -2.5      | V          |
| I <sub>DSS</sub>    | Drain-Source Leakage Current                   | $V_{DS}=-40V, V_{GS}=0V, T_J=25^\circ\text{C}$    | ---  | ---  | -1        | $\mu A$    |
|                     |                                                | $V_{DS}=-40V, V_{GS}=0V, T_J=125^\circ\text{C}$   | ---  | ---  | -100      |            |
| I <sub>GSS</sub>    | Gate-Source Leakage Current                    | $V_{GS}=\pm 20V, V_{DS}=0V$                       | ---  | ---  | $\pm 100$ | nA         |
| R <sub>g</sub>      | Gate Resistance                                | $V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$             | ---  | 1.7  | ---       | $\Omega$   |
| Q <sub>g</sub>      | Total Gate Charge                              | $V_{DS}=-20V, V_{GS}=-10V, I_D=-20A$              | ---  | 137  | ---       | nC         |
| Q <sub>gs</sub>     | Gate-Source Charge                             |                                                   | ---  | 25   | ---       |            |
| Q <sub>gd</sub>     | Gate-Drain Charge                              |                                                   | ---  | 30   | ---       |            |
| T <sub>d(on)</sub>  | Turn-On Delay Time                             | $V_{DD}=-20V, V_{GS}=-10V, R_G=3\Omega, I_D=-10A$ | ---  | 18   | ---       | ns         |
| T <sub>r</sub>      | Rise Time                                      |                                                   | ---  | 3.6  | ---       |            |
| T <sub>d(off)</sub> | Turn-Off Delay Time                            |                                                   | ---  | 21   | ---       |            |
| T <sub>f</sub>      | Fall Time                                      |                                                   | ---  | 39   | ---       |            |
| C <sub>iss</sub>    | Input Capacitance                              | $V_{DS}=-20V, V_{GS}=0V, f=1\text{MHz}$           | ---  | 6759 | ---       | pF         |
| C <sub>oss</sub>    | Output Capacitance                             |                                                   | ---  | 653  | ---       |            |
| C <sub>rss</sub>    | Reverse Transfer Capacitance                   |                                                   | ---  | 448  | ---       |            |

**Diode Characteristics**

| Symbol          | Parameter                                | Conditions                                             | Min. | Typ. | Max. | Unit |
|-----------------|------------------------------------------|--------------------------------------------------------|------|------|------|------|
| I <sub>S</sub>  | Continuous Source Current <sup>1,5</sup> | $V_G=V_D=0V$ , Force Current                           | ---  | ---  | -115 | A    |
| V <sub>SD</sub> | Diode Forward Voltage <sup>2</sup>       | $I_S = -20A, V_{GS}=0V, T_J=25^\circ\text{C}$          | ---  | ---  | -1.2 | V    |
| t <sub>rr</sub> | Reverse Recovery Time                    | $I_F = -20A, di/dt = 100A/\mu s, T_J=25^\circ\text{C}$ | ---  | 52   | ---  | nS   |
| Q <sub>rr</sub> | Reverse Recovery Charge                  |                                                        | ---  | 128  | ---  | nC   |

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.
2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .
3. The EAS data shows Max. rating. The test condition is  $V_{DD}=-40V, V_{GS}=-10V, L=0.5mH, I_{AS}=-70.7A$ .
4. The power dissipation is limited by  $150^\circ\text{C}$  junction temperature.
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.

### Typical Characteristics

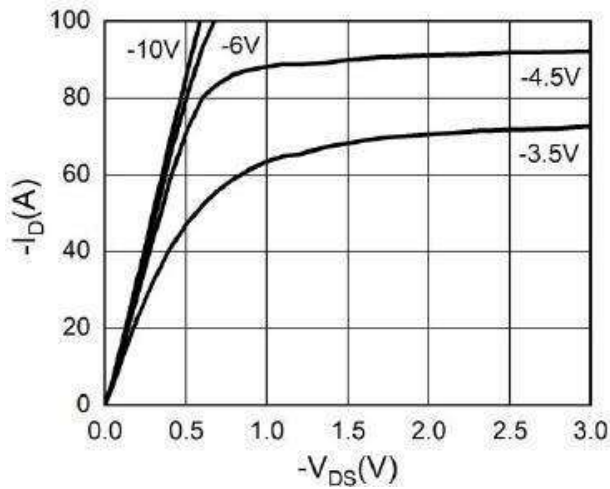


Fig.1 Typical Output Characteristics

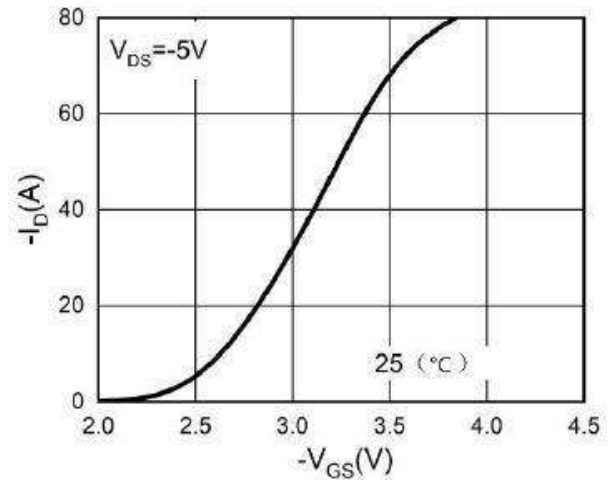


Fig.2 Transfer Characteristics

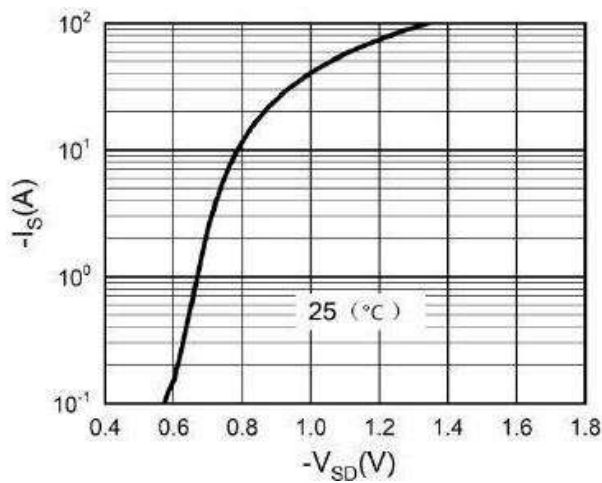


Fig.3 Forward Characteristics Of Reverse

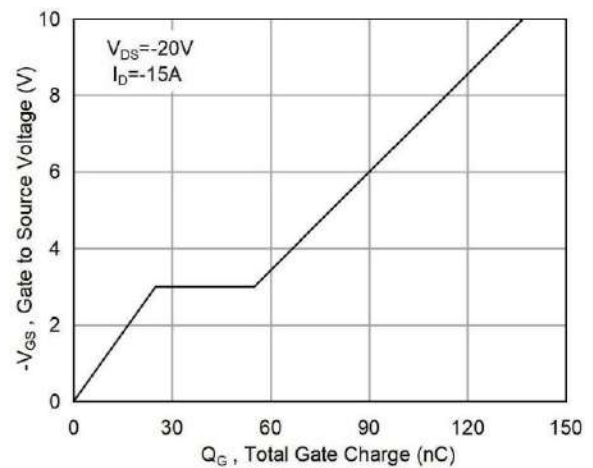


Fig.4 Gate-Charge Characteristics

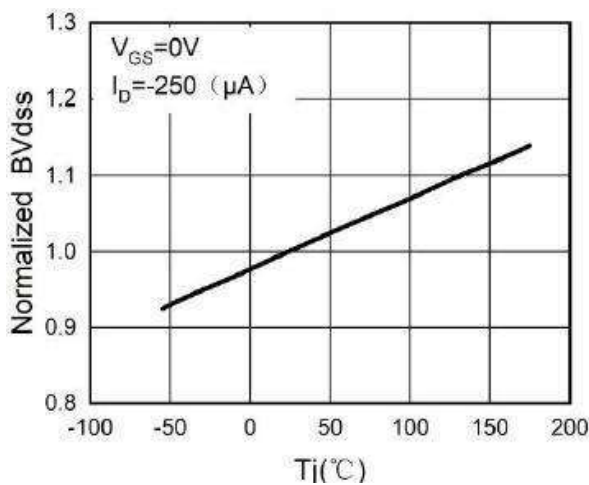


Fig.5 Normalized  $BV_{DS}$  v.s  $T_J$

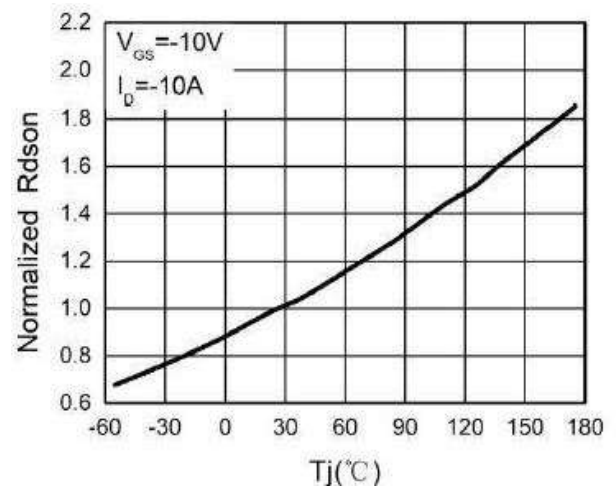
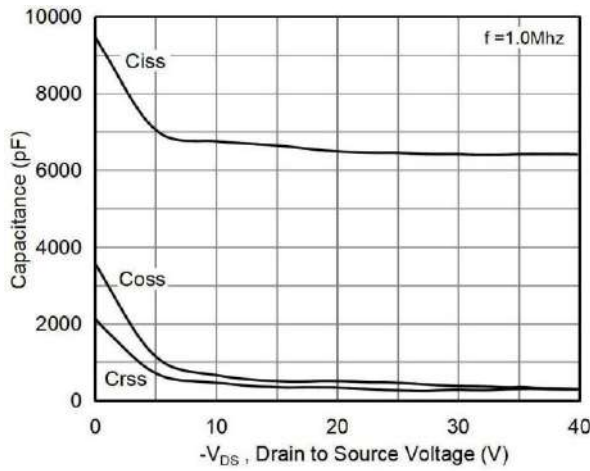
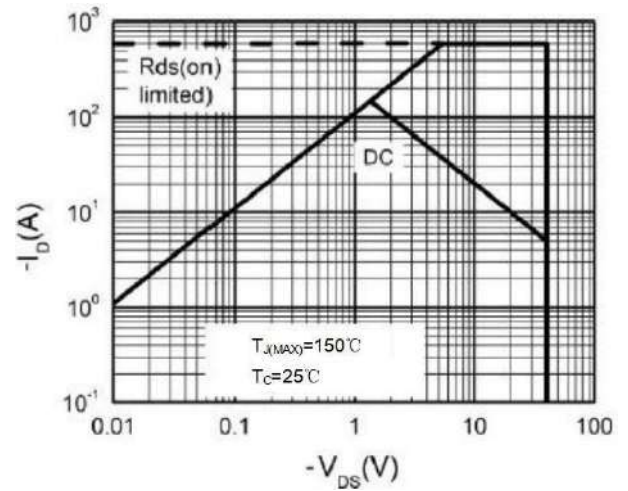


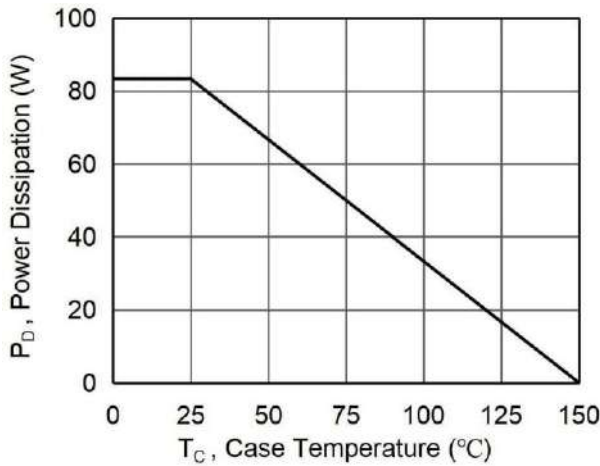
Fig.6 Normalized  $R_{DS(on)}$  v.s  $T_J$



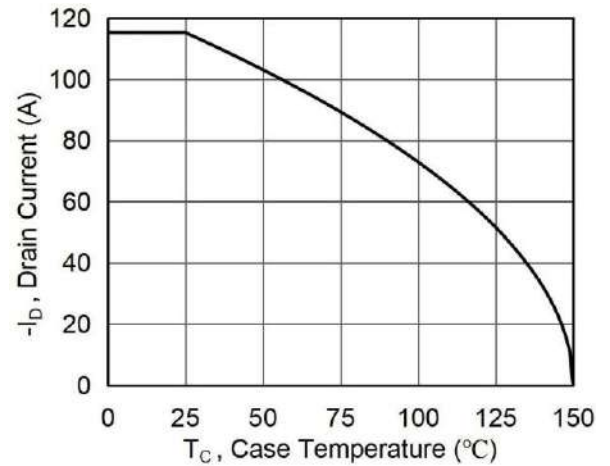
**Fig.7 Capacitance**



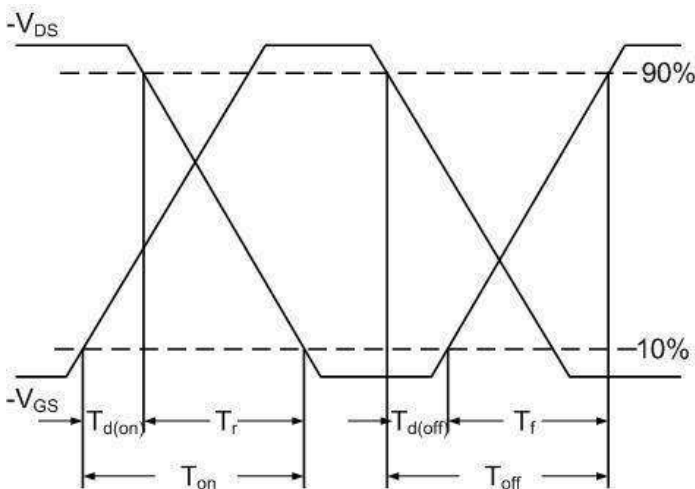
**Fig.8 Safe Operating Area**



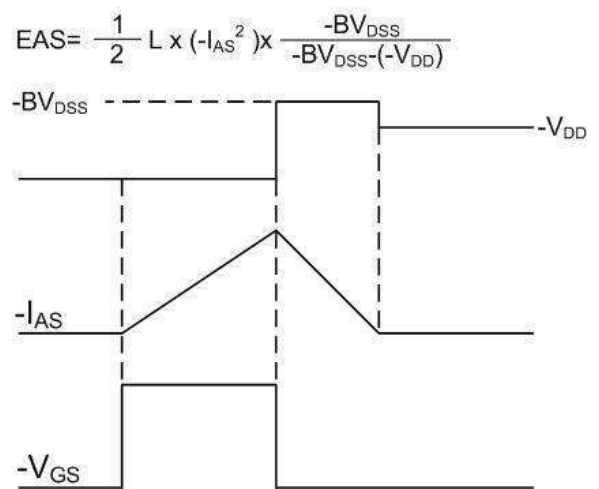
**Fig.9 Power Dissipation**



**Fig.10 Drain Current**



**Fig.11 Switching Time Waveform**



**Fig.12 Unclamped Inductive Waveform**